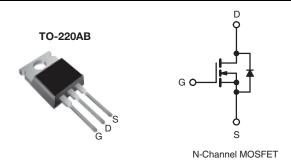


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V 0.050				
Q _g (Max.) (nC)	35				
Q _{gs} (nC)	7.1				
Q _{gd} (nC)	25				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Load (Dh) fron	IRLZ34PbF		
Lead (Pb)-free	SiHLZ34-E3		
SnPb	IRLZ34		
SIFD	SiHLZ34		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 10		
Continuous Drain Current	V _{GS} at 5 V	T _C = 25 °C	- I _D	30		
Continuous Drain Current		$T_C = 25 \degree C$ $T_C = 100 \degree C$		21	Α	
Pulsed Drain Current ^a			I _{DM}	110	1	
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	128	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	88	W	
Peak Diode Recovery dV/dt ^c	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Modifiling Forque				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, Starting $T_J=25$ °C, L=285 μH , $R_g=25$ Ω , $I_{AS}=30$ A (see fig. 12).
- c. $I_{SD} \le 30$ A, $dI/dt \le 200$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$) V, I _D = 250 μA	60	-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	1.0	-	2.0	٧
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V		1	-	25	μА
Zero date voltage Drain ourrent		V _{DS} = 48 V, V	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	B	$V_{GS} = 5.0 \text{ V}$	I _D = 18 A ^b	-	-	0.050	Ω
Diam-Source On-State Hesistance	R _{DS(on)}	$V_{GS} = 4.0 \text{ V}$	I _D = 15 A ^b	-	-	0.070	
Forward Transconductance	9fs	$V_{DS} = 2$	25 V, I _D = 18 A ^b	12	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	$t_{GS} = 0 \text{ V},$	-	1600	-	
Output Capacitance	C _{oss}	V _I	V _{DS} = 25 V,		660	-	pF
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		-	170	-	
Total Gate Charge	Q_g		$I_D = 30 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13^b	-	-	35	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 5.0 V		1	-	7.1	
Gate-Drain Charge	Q_{gd}			-	-	25	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 30 V, I_{D} = 30 A R_{q} = 6.0 Ω , R_{D} = 1.0 Ω , see fig. 10 ^b		_	14	-	ns
Rise Time	t _r			-	170	-	
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f	g		1	56	-]
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s				•	,	
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	30	A
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	110	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 30 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		1	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T. = 25 °C L =	30 A dl/dt = 100 A/usb	-	120	180	ns
Body Diode Reverse Recovery Charge	Q_{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 30 \text{A}, dI/dt = 100 \text{A}/\mu \text{s}^{\text{b}}$		-	0.70	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on is do	minated b	by L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

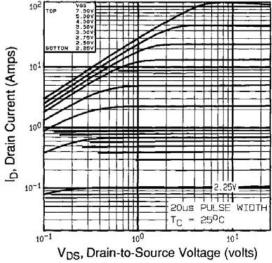


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

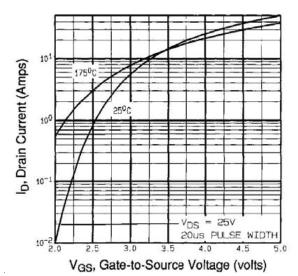


Fig. 3 - Typical Transfer Characteristics

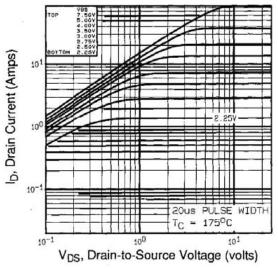


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

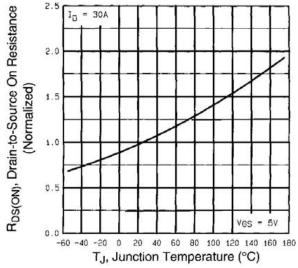


Fig. 4 - Normalized On-Resistance vs. Temperature



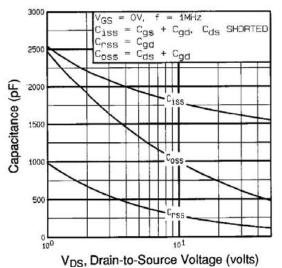


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

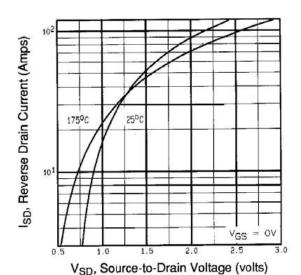


Fig. 7 - Typical Source-Drain Diode Forward Voltage

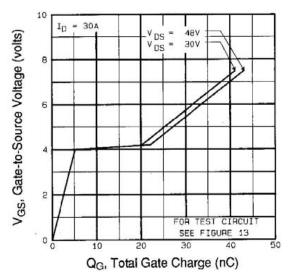


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage

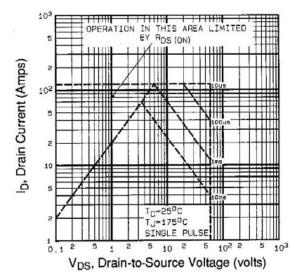


Fig. 8 - Maximum Safe Operating Area





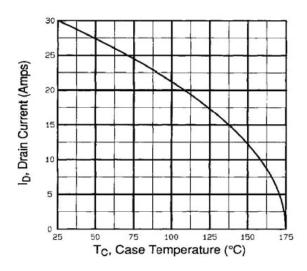


Fig. 9 - Maximum Drain Current vs. Case Temperature

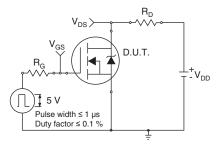


Fig. 10a - Switching Time Test Circuit

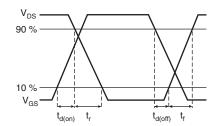


Fig. 10b - Switching Time Waveforms

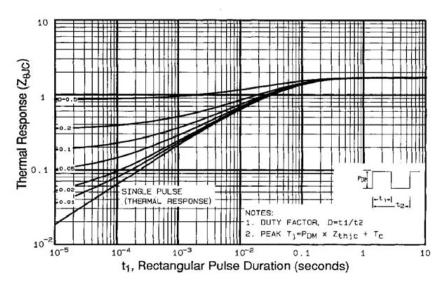


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



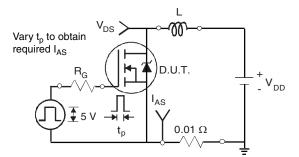


Fig. 12a - Unclamped Inductive Test Circuit

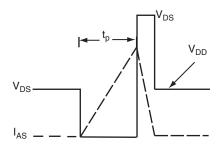


Fig. 12b - Unclamped Inductive Waveforms

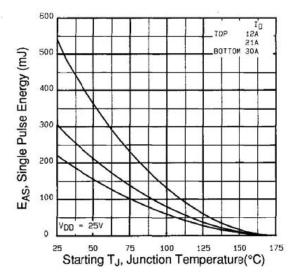


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

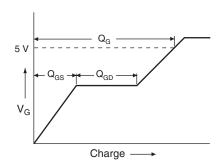


Fig. 13a - Basic Gate Charge Waveform

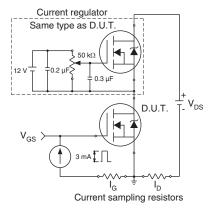
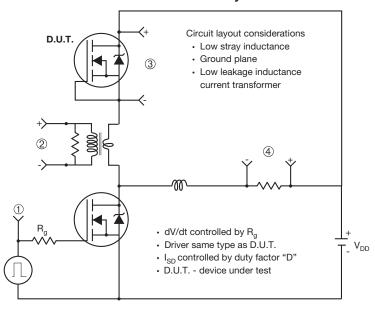


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



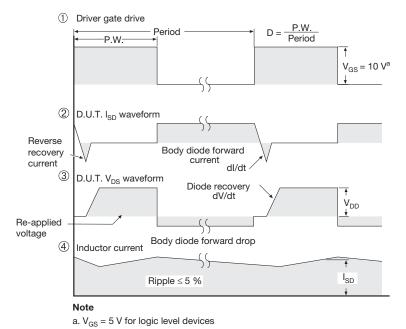
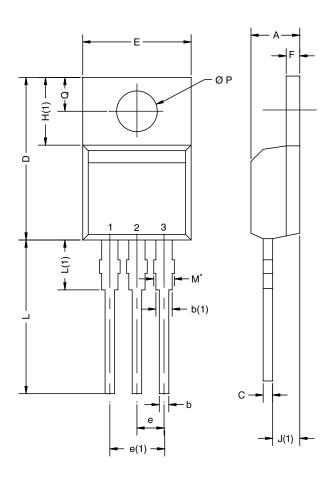


Fig. 14 - For N-Channel

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TO-220AB



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: T13-0724-Rev. O, 14-Oct-13						

DWG: 5471

Note

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Vishay

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Revision: 02-Oct-12 Document Number: 91000